

CX11L TELEMETRY CRYSTAL

16 MHz to 250 MHz

Telemetry, Ultra Low Profile, Ultra-Miniature Surface Mount Quartz Crystal

DESCRIPTION

When miniaturization is paramount, Statek's low profile CX11L AT quartz crystal is an excellent choice. Available in frequencies from 16 MHz to 250 MHz, this crystal has a typical footprint of 3.2 mm x 1.5 mm, and a typical height of 0.5 mm. The resonator is manufactured using Statek's photolithographic and chemical milling processes and then sealed within a ceramic package for high stability and low aging. Available with tight calibration tolerances and high stability over temperature, this crystal is well suited for applications that have a space restraint and require a crystal with a low profile.

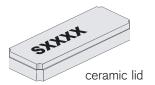


- Ultra-miniature, surface mount design
- Ultra-low profile
- Hermetically sealed ceramic package
- High shock and vibration survival
- Excellent aging characteristics
- Full military testing available
- Designed and manufactured in the USA

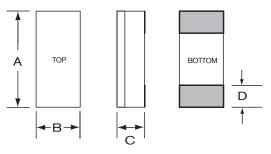
APPLICATIONS

Medical

- Medical Telemetry
- Pacemakers
- Defibrillators
- Neurostimulators
- Infusion Pumps
- Cochlear Implants



PACKAGE DIMENSIONS

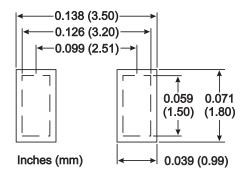


	TYPICAL		MAXIMUM		
DIM	inches	mm	inches	mm	
Α	0.127	3.20	0.135	3.43	
В	0.060	1.50	0.068	1.73	
С	-	-	see b	elow	
D	0.028	0.71	0.037	0.94	

THICKNESS (DIM C)

Lid	Termination	Typical		Maximum	
		inches	mm	inches	mm
Ceramic	SM1	0.020	0.51	0.023	0.59
	SM2/SM4	0.021	0.53	0.024	0.61
	SM3/SM5	0.022	0.56	0.025	0.64

SUGGESTED LAND PATTERN



10188 Rev C



SPECIFICATIONS

Specifications are typical at 25°C unless otherwise noted. Specifications are subject to change without notice.

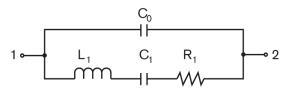
Fundamental Frequency	<u>16 MHz</u>	<u>24 MHz</u>	26.5 MHz	
Motional Resistance $R_1(\Omega)$	90	30	30	
Motional Capacitance C ₁ (fF) 1.5	1.4	1.6	
Quality Factor Q (k)	70	150	120	
Shunt Capacitance C ₀ (pF)	0.7	0.7	0.7	
Calibration Tolerance ¹	±100 ppm,	or tighter as	required	
Load Capacitance	10 pF (unles	ss specified	otherwise)	
Drive Level	200 μW MA	X		
Frequency-Temperature	±50 ppm to ±10 ppm (Commercial)			
Stability ^{1,2}	± 100 ppm to ± 20 ppm (Industrial)			
	±100 ppm t	o ±30 ppm	(Military)	
Aging, first year	3 ppm MAX	(better than 1	ppm available)	
Shock, survival	5,000 g, 0.3	3 ms, 1/2 si	ne	
Vibration, survival ³	20 g, 10-2,	000 Hz swe	pt sine	
Operating Temp. Range	-10°C to +7 -40°C to +8 -55°C to +1	85°C (Indus	trial)	
Storage Temp. Range	-55°C to +1	25°C		
Max Process Temperature	260°C for 2	0 sec.		

- 1. Other tolerances available. Contact factory.
- Does not include calibration tolerance. The characteristics of the frequency stability over temperature follow that of the AT thickness-shear mode.
- ${\it 3. Per MIL-STD-202G, Method 204D, Condition D. Random vibration testing also available.}$

TERMINATIONS

D	<u>esignation</u>	<u>Iermination</u>
SI	M1	Gold Plated (Lead Free)
SI	M2	Solder Plated
SI	M3	Solder Dipped
SI	M4	Solder Plated (Lead Free)
SI	M5	Solder Dipped (Lead Free)

EQUIVALENT CIRCUIT



 R_1 Motional Resistance L_1 Motional Inductance C_1 Motional Capacitance C_0 Shunt Capacitance

PACKAGING OPTIONS

- Tray Pack
- 12 mm tape, 7" or 13" reels
 Per EIA 481 (see Tape and Reel data sheet 10109)

HOW TO ORDER LOW PROFILE CX11L AT CRYSTALS

